

Support Information

Proposed electron transmission mechanism between $\text{Fe}^{3+}/\text{Co}^{2+}$ and $\text{Fe}^{3+}/\text{Fe}^{3+}$ in spinel structure and its practical evidence on quaternary



Hualiang Lv,^a Haiqian Zhang,^a Baoshan Zhang,^b Guangbin Ji,^{a,*} Yun He,^c Qing Lin^c

^a*College of Material Science and Technology, Nanjing University of Aeronautics and Astronautics, Nanjing 210016, P. R. China*

^b*School of Electronic Science and Engineering, Nanjing University, Nanjing 210093, P. R. China*

^c*College of Physics and Technology, Guangxi Normal University, Guilin 541004, China*

*Corresponding Author:

Prof. Dr. Guangbin Ji.

Tel: +86-25-52112902; Fax: +86-25-52112626

E-mail: gaji@nuaa.edu.cn

Table S1. The etching parameters of the two samples.

Sample	Etching element	Source Gun Tyoe	Total acquisit ion time	Number of Energy steps	Eney step Size	Etching Time
$\text{Fe}_{0.5}\text{Ni}_{0.5}\text{Co}_2\text{O}_4$	Ar ion	Al K α	1 min 8.0 secs	1361	1.00 eV	~3000 s
$\text{Fe}_{0.5}\text{Ni}_{0.5}\text{Co}_2\text{S}_4$	Ar iron	Al K α	1 min 8.0 secs	1361	1.000 eV	~3000 s

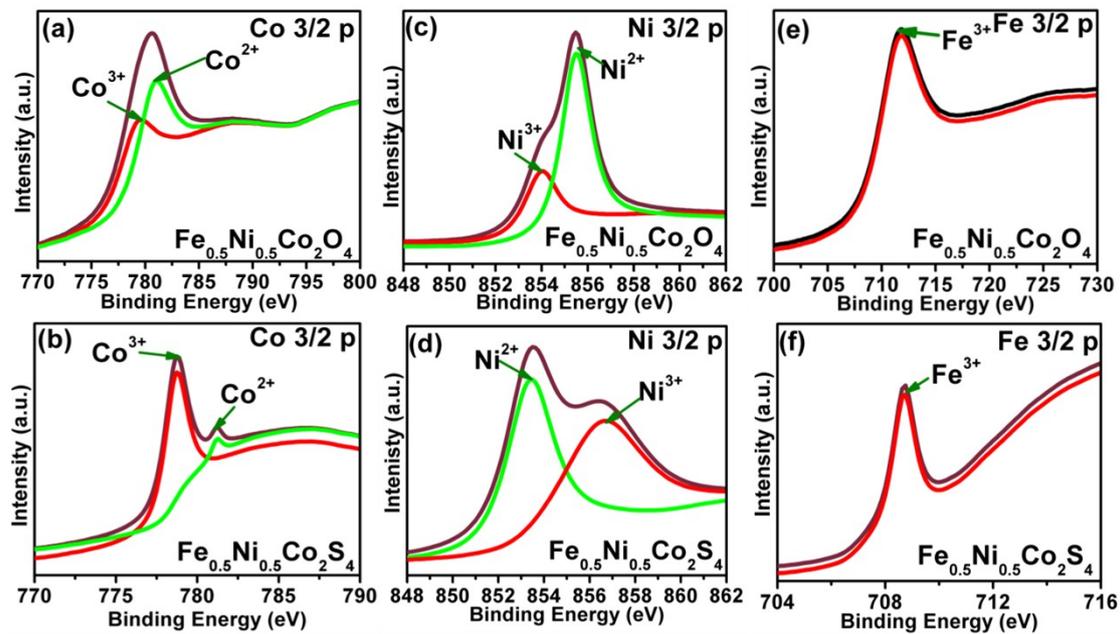


Figure S1. XPS data of $\text{Fe}_{0.5}\text{Ni}_{0.5}\text{Co}_2\text{O}_4$ and $\text{Fe}_{0.5}\text{Ni}_{0.5}\text{Co}_2\text{S}_4$ treated by Ar-cluster etching technique: (a, c, e): Co 3/2p, Ni 3/2p, Fe 3/2p of $\text{Fe}_{0.5}\text{Ni}_{0.5}\text{Co}_2\text{O}_4$; (b, d, f) Co3/2p, Ni 3/2p, Fe 3/2p of $\text{Fe}_{0.5}\text{Ni}_{0.5}\text{Co}_2\text{S}_4$.

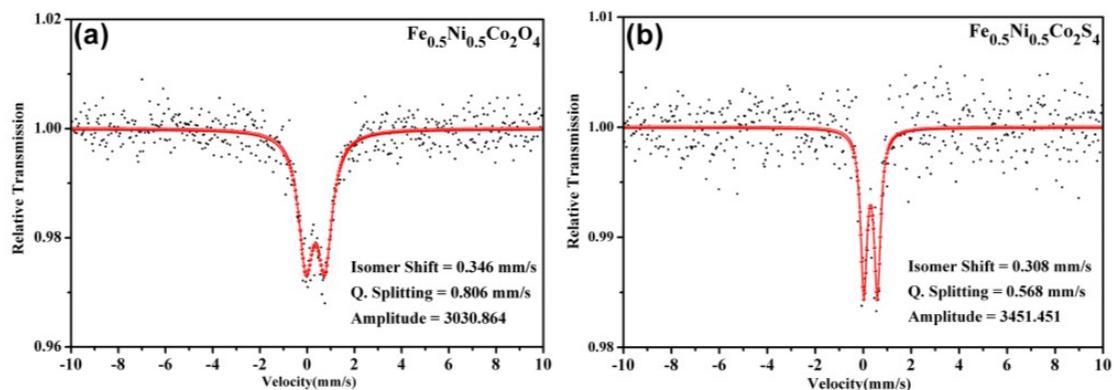


Figure S2. The Mössbauer of $\text{Fe}_{0.5}\text{Ni}_{0.5}\text{Co}_2\text{O}_4$ and $\text{Fe}_{0.5}\text{Ni}_{0.5}\text{Co}_2\text{S}_4$.

According to the Isomer shift value, we can get information that the Fe ions in both two samples presented tervalence. Besides, Fe³⁺ only can be found at B sites.¹⁻²

[1] S.J. Kim, C.S.Kim; *Journal of the Korean Physical Society*, 2014, 64, 852-856.

[2] D. Polikarpov, V. Cherepanov, M. Chuev, R. Gabbasov, I. Mischenko, M. Nikitin, Y. Vereshagin, A. Yurenia, V. Panchenko. *Hyperfine Interace*, 2014, 226, 421–430.